

## STN3N45K3 STQ3N45K3-AP, STU3N45K3

N-channel 450 V, 3.2 Ω, 1.8 A, TO-92, SOT-223, IPAK SuperMESH3™ Power MOSFET

Preliminary data

#### **Features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>	Pw
STN3N45K3	450 V	< 3.8 Ω	0.6 A	2 W
STQ3N45K3-AP	450 V	< 3.8 Ω	0.6 A	2.5 W
STU3N45K3	450 V	< 3.8 Ω	1.8 A	27 W

- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitance
- Improved diode reverse recovery characteristics
- Zener-protected

#### **Application**

Switching applications

### **Description**

The new SuperMESH3™ series is obtained through the combination of a further fine tuning of ST's well established strip-based PowerMESH™ layout with a new optimization of the vertical structure. In addition to reducing on-resistance significantly versus previous generation, special attention has been taken to ensure a very good dv/dt capability and higher margin in breakdown voltage for the most demanding application.

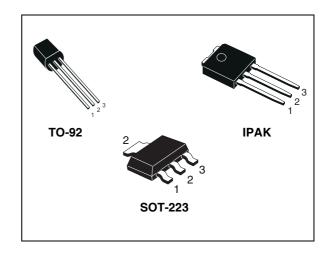


Figure 1. Internal schematic diagram

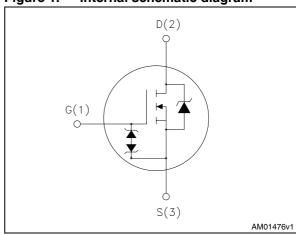


Table 1. Device summary

Order codes	odes Marking		Packaging
STN3N45K3	3N45K3	SOT-223	Tube
STQ3N45K3-AP	3N45K3	TO-92	Ammopak
STU3N45K3	3N45K3	IPAK	Tube

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# 1 Electrical ratings

Table 2. Absolute maximum ratings

Cumbal	Parameter		- Unit		
Symbol	Farameter	SOT-223	TO-92	IPAK	
$V_{DS}$	Drain-source voltage (V <sub>GS</sub> = 0)		450		V
V <sub>GS</sub>	Gate- source voltage	± 30			٧
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	0.6		1.8	Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	0.38		1	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	2.4		7.2	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	2 2.5		27	W
T <sub>stg</sub>	Storage temperature	-55 to 150		°C	
Tj	Max. operating junction temperature		150		°C

<sup>1.</sup> Pulse width limited by safe operating area.

Table 3. Thermal data

Symbol	Parameter	SOT-223 TO-92 IPAK		IPAK	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	62.50 50 4.63		4.63	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient max			100	°C/W
T <sub>I</sub>	Maximum lead temperature for soldering purpose	300		°C	

Table 4. Avalanche characteristics

Symbol	Parameter Max value		Unit
I <sub>AR</sub>	Avalanche current, repetitive or not- repetitive (pulse width limited by $T_j$ max)	0.5	Α
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_j = 25^{\circ}C$ , $I_D = I_{AR}$ , $V_{DD} = 50V$ )	TBD	

## 2 Electrical characteristics

 $(T_C = 25 \, ^{\circ}C \text{ unless otherwise specified})$ 

Table 5. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0	450			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	$V_{DS}$ = Max rating $V_{DS}$ = Max rating, $T_{C}$ =125 °C			1 50	μ <b>Α</b> μ <b>Α</b>
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			± 10	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 50 \mu A$	3	3.75	4.5	٧
R <sub>DS(on</sub>	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 0.5 \text{ A}$		3.2	3.8	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz, V}_{GS} = 0$	-	150 30 6	-	pF pF pF
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz open drain	-	TBD	-	Ω
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD}$ = 360 V, $I_D$ = 1.8 A, $V_{GS}$ = 10 V (see <i>Figure 3</i> )	1	6 TBD TBD	-	nC nC nC

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
$\begin{array}{c} t_{\text{d(on)}} \\ t_{\text{r}} \\ t_{\text{d(off)}} \\ t_{\text{f}} \end{array}$	Turn-on delay time Rise time Turn-off-delay time Fall time	$V_{DD} = 225 \text{ V}, I_{D} = 0.5 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 2</i> )	-	TBD TBD TBD TBD	-	ns ns ns ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current Source-drain current (pulsed)		-		1.8 7.2	A A
V <sub>SD</sub> (2)	Forward on voltage	I <sub>SD</sub> = 1.8 A, V <sub>GS</sub> = 0	-		TBD	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>SD</sub> = 1.8 A, di/dt = 100 A/μs V <sub>DD</sub> = 100 V (see <i>Figure 7</i> )	1	TBD TBD TBD		ns nC A
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 1.8 \text{ A, di/dt} = 100 \text{ A/µs}$ $V_{DD} = 100 \text{ V, T}_j = 150 ^{\circ}\text{C}$ (see <i>Figure 7</i> )	-	TBD TBD TBD		ns nC A

- 1. Pulse width limited by safe operating area.
- 2. Pulsed: Pulse duration =  $300 \mu s$ , duty cycle 1.5%.

Table 9. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min	Тур	Max	Unit
BV <sub>GSO</sub>	Gate-source breakdown voltage	Igs=± 1 mA (open drain)	30		-	٧

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

### 3 Test circuits

Figure 2. Switching times test circuit for resistive load

Figure 3. Gate charge test circuit

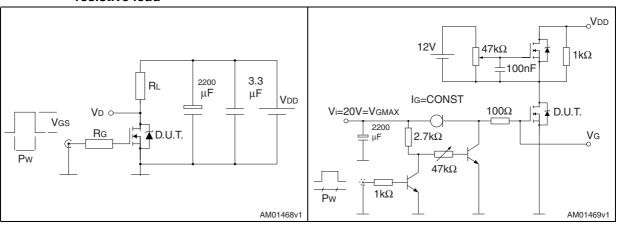


Figure 4. Test circuit for inductive load switching and diode recovery times

Figure 5. Unclamped Inductive load test circuit

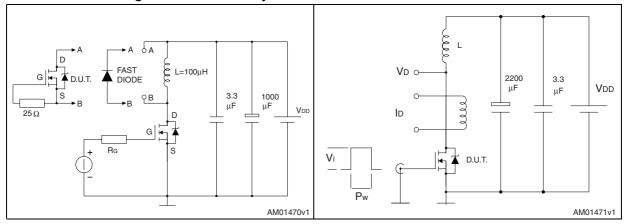
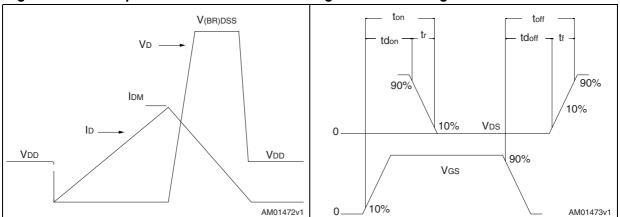


Figure 6. Unclamped inductive waveform

Figure 7. Switching time waveform



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# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

#### SOT-223 mechanical data

DIM.		mm.					
Dilvi.	min.	typ	max.				
Α			1.80				
A1	0.02		0.1				
В	0.60	0.70	0.85				
B1	2.90	3.00	3.15				
С	0.24	0.26	0.35				
D	6.30	6.50	6.70				
е		2.30					
e1		4.60					
E	3.30	3.50	3.70				
Н	6.70	7.00	7.30				
V			10 °				

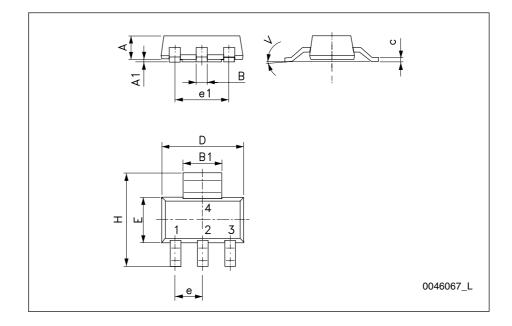
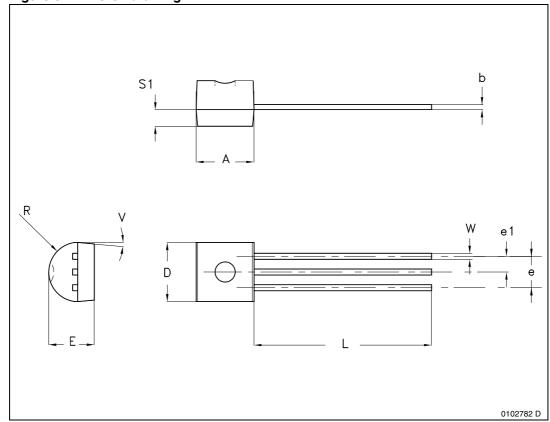


Table 10. TO-92 mechanical data

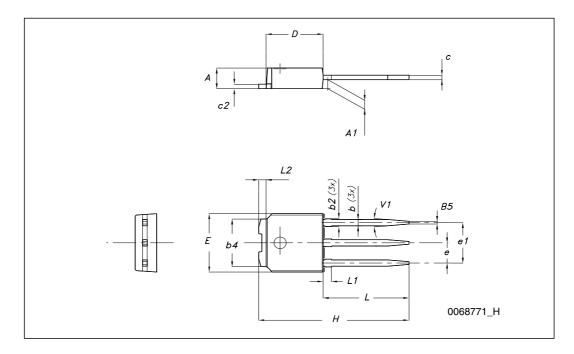
Dim.	mm			
	Min.	Тур.	Max.	
Α	4.32		4.95	
b	0.36		0.51	
D	4.45		4.95	
Е	3.30		3.94	
е	2.41		2.67	
e1	1.14		1.40	
L	12.70		15.49	
R	2.16		2.41	
S1	0.92		1.52	
W	0.41		0.56	
V		5°		

Figure 8. TO-92 drawing



### TO-251 (IPAK) mechanical data

DIM	mm.			
DIM.	min.	typ	max.	
Α	2.20		2.40	
A1	0.90		1.10	
b	0.64		0.90	
b2			0.95	
b4	5.20		5.40	
С	0.45		0.60	
c2	0.48		0.60	
D	6.00		6.20	
E	6.40		6.60	
е		2.28		
e1	4.40		4.60	
Н		16.10		
L	9.00		9.40	
(L1)	0.80		1.20	
L2		0.80		
V1		10 °		



# 5 Revision history

Table 11. Document revision history

Date	Revision	Changes
02-Mar-2010	1	First release
23-Apr-2010	2	Changed root part number

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